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Application/Control No.	Applicant(s)/Patent under Reexamination
10/092,662	YANO ET AL.
Examiner	Art Unit
Belix M. Ortiz	2164

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Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH :)
	DATE	EXMR
Searched -east, uspat, us pgpub	6/5/2006	вмо
search class 707, using keywords search. search strategies are enclosed	6/5/2006	вмо
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